

## 2 OUTPUT PCIE GEN1/2 SYNTHESIZER

IDT5V41065

### Recommended Applications

2 Output synthesizer for PCIe Gen1/2 and Ethernet

### General Description

The IDT5V41065 is a PCIe Gen2 compliant spread spectrum capable clock generator. The device has 2 differential HCSL outputs and can be used in communication or embedded systems to substantially reduce electro-magnetic interference (EMI). The spread amount and output frequency are selectable via select pins. The IDT5V41065 can also supply 25 MHz and 200 MHz outputs for applications such as Ethernet.

### Output Features

- 2 - 0.7V current mode differential HCSL output pairs

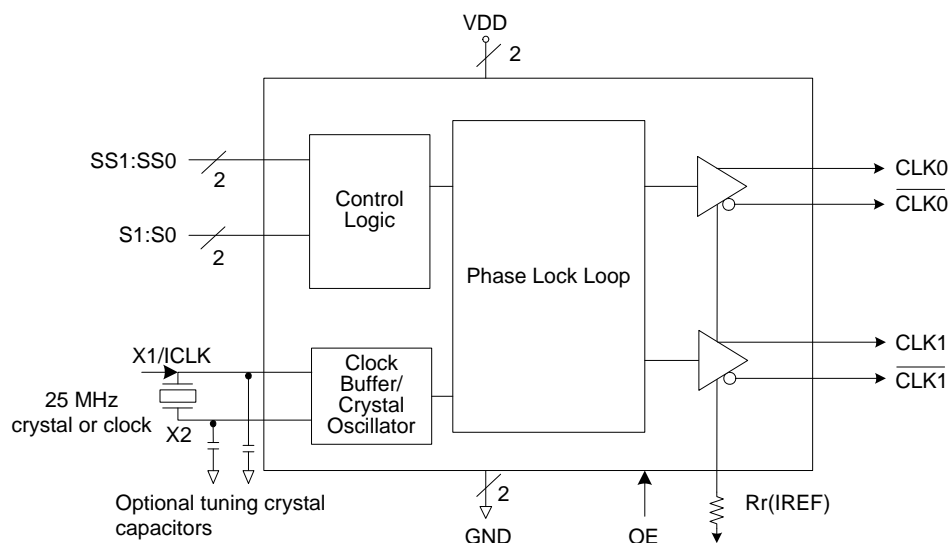
### Features/Benefits

- 16-pin TSSOP package; small board footprint
- Spread-spectrum capable; reduces EMI
- Outputs can be terminated to LVDS; can drive a wider variety of devices
- 25 MHz, 125 MHz and 200 MHz output frequencies; supports Ethernet applications
- OE control pin; greater system power management
- Spread% and frequency pin selection; no software required to configure device
- Industrial temperature range available; supports demanding embedded applications
- **For PCIe Gen3 applications, see the 5V41235**

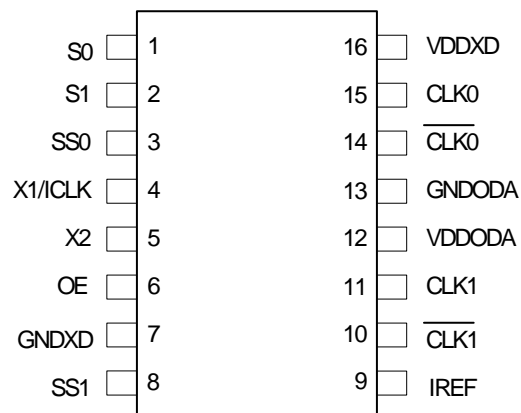
### Key Specifications

- Cycle-to-cycle jitter < 100 ps
- Output-to-output skew < 50 ps
- PCIe Gen2 phase jitter < 3.0ps RMS

### Block Diagram



## Pin Assignment



16-pin (173 mil) TSSOP

## Output Select Table 1 (MHz)

S1	S0	CLK(1:0), $\overline{\text{CLK}}(1:0)$
0	0	25M
0	1	100M
1	0	125M
1	1	200M

## Spread Selection Table 2

SS1	SS0	Spread%
0	0	No Spread
0	1	Down -0.5
1	0	Down -0.75
1	1	No Spread

## Pin Descriptions

Pin Number	Pin Name	Pin Type	Pin Description
1	S0	Input	Select pin 0. See Table1. Internal pull-up resistor.
2	S1	Input	Select pin 1. See Table 1. Internal pull-up resistor.
3	SS0	Input	Spread Select pin 0. See Table 2. Internal pull-up resistor.
4	X1/ICLK	Input	Crystal or clock input. Connect to a 25 MHz crystal or single ended clock.
5	X2	Output	Crystal connection. Leave unconnected for clock input.
6	OE	Input	Output enable. Tri-states outputs and device is not shut down. Internal pull-up resistor.
7	GNDXD	Power	Connect to ground.
8	SS1	Input	Spread Select pin 1. See Table 2. Internal pull-up resistor.
9	IREF	Output	Precision resistor attached to this pin is connected to the internal current reference.
10	CLK1	Output	HCSL complementary clock output 1.
11	CLK1	Output	HCSL true clock output 1.
12	VDDODA	Power	Connect to voltage supply +3.3 V for output driver and analog circuits
13	GNDODA	Power	Connect to ground.
14	CLK0	Output	HCSL complementary clock output 0.
15	CLK0	Output	HCSL true clock output 0.
16	VDDXD	Power	Connect to voltage supply +3.3 V for crystal oscillator and digital circuit.

## Applications Information

### External Components

A minimum number of external components are required for proper operation.

### Decoupling Capacitors

Decoupling capacitors of 0.01  $\mu\text{F}$  should be connected between each VDD pin and the ground plane, as close to the VDD pin as possible. Do not share ground vias between components. Route power from power source through the capacitor pad and then into ICS pin.

### Crystal

A 25 MHz fundamental mode parallel resonant crystal should be used. This crystal must have less than 300 ppm of error across temperature in order for the IDT5V41065 to meet PCI Express specifications.

### Crystal Capacitors

Crystal capacitors are connected from pins X1 to ground and X2 to ground to optimize the accuracy of the output frequency.

$C_L$  = Crystal's load capacitance in pF

Crystal Capacitors (pF) =  $(C_L - 8) * 2$

For example, for a crystal with a 16 pF load cap, each external crystal cap would be 16 pF.  $(16 - 8) * 2 = 16$ .

Current Source ( $I_{ref}$ ) Reference Resistor -  $R_R$

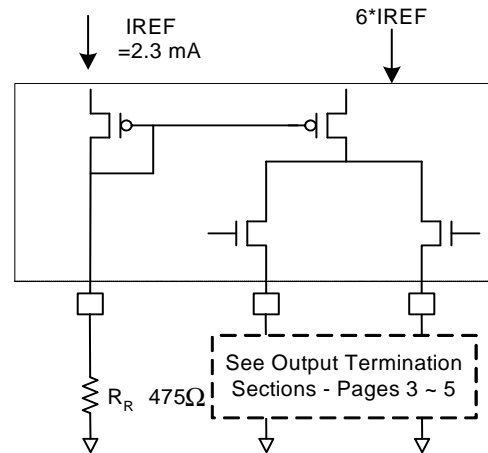
If board target trace impedance ( $Z$ ) is  $50\Omega$ , then  $R_R = 475\Omega$  (1%), providing  $I_{REF}$  of 2.32 mA. The output current ( $I_{OH}$ ) is equal to  $6 * I_{REF}$ .

### Output Termination

The PCI-Express differential clock outputs of the IDT5V41065 are open source drivers and require an external series resistor and a resistor to ground. These resistor values and their allowable locations are shown in detail in the **PCI-Express Layout Guidelines** section.

The IDT5V41065 can also be configured for LVDS compatible voltage levels. See the **LVDS Compatible Layout Guidelines** section.

## Output Structures



## General PCB Layout Recommendations

For optimum device performance and lowest output phase noise, the following guidelines should be observed.

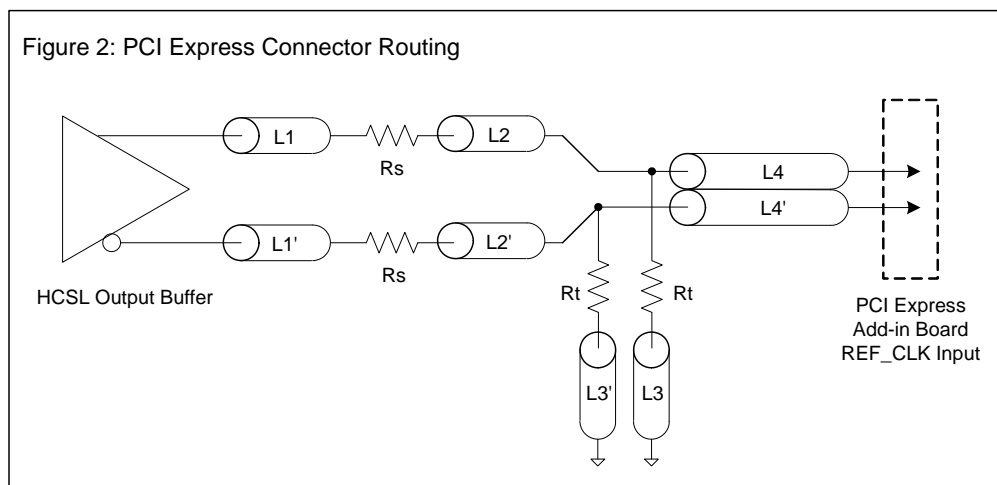
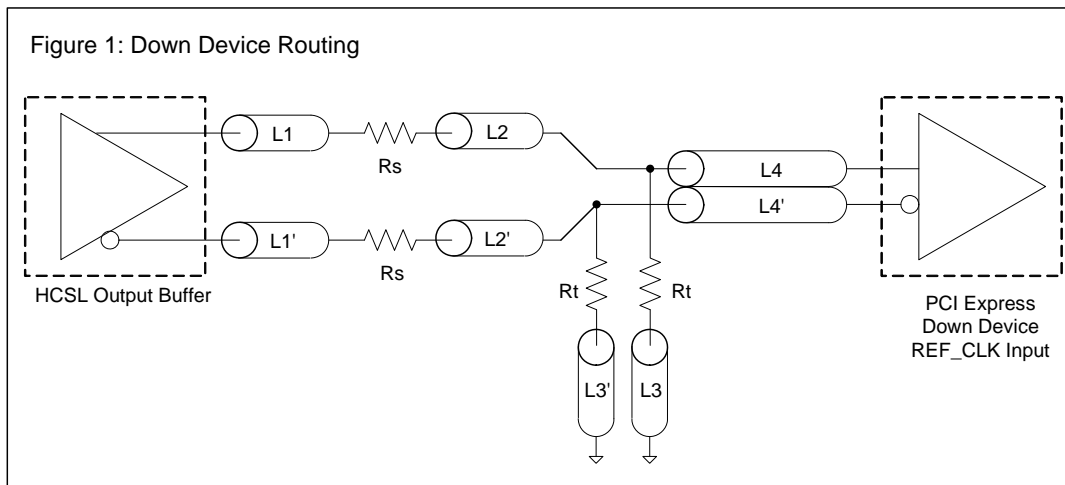
1. Each 0.01  $\mu\text{F}$  decoupling capacitor should be mounted on the component side of the board as close to the VDD pin as possible.
2. No vias should be used between decoupling capacitor and VDD pin.
3. The PCB trace to VDD pin should be kept as short as possible, as should the PCB trace to the ground via. Distance of the ferrite bead and bulk decoupling from the device is less critical.
4. An optimum layout is one with all components on the same side of the board, minimizing vias through other signal layers (any ferrite beads and bulk decoupling capacitors can be mounted on the back). Other signal traces should be routed away from the IDT5V41065. This includes signal traces just underneath the device, or on layers adjacent to the ground plane layer used by the device.

## Layout Guidelines

SRC Reference Clock			
Common Recommendations for Differential Routing	Dimension or Value	Unit	Figure
L1 length, route as non-coupled 50ohm trace	0.5 max	inch	1
L2 length, route as non-coupled 50ohm trace	0.2 max	inch	1
L3 length, route as non-coupled 50ohm trace	0.2 max	inch	1
Rs	33	ohm	1
Rt	49.9	ohm	1

Down Device Differential Routing			
L4 length, route as coupled microstrip 100ohm differential trace	2 min to 16 max	inch	1
L4 length, route as coupled stripline 100ohm differential trace	1.8 min to 14.4 max	inch	1

Differential Routing to PCI Express Connector			
L4 length, route as coupled microstrip 100ohm differential trace	0.25 to 14 max	inch	2
L4 length, route as coupled stripline 100ohm differential trace	0.225 min to 12.6 max	inch	2

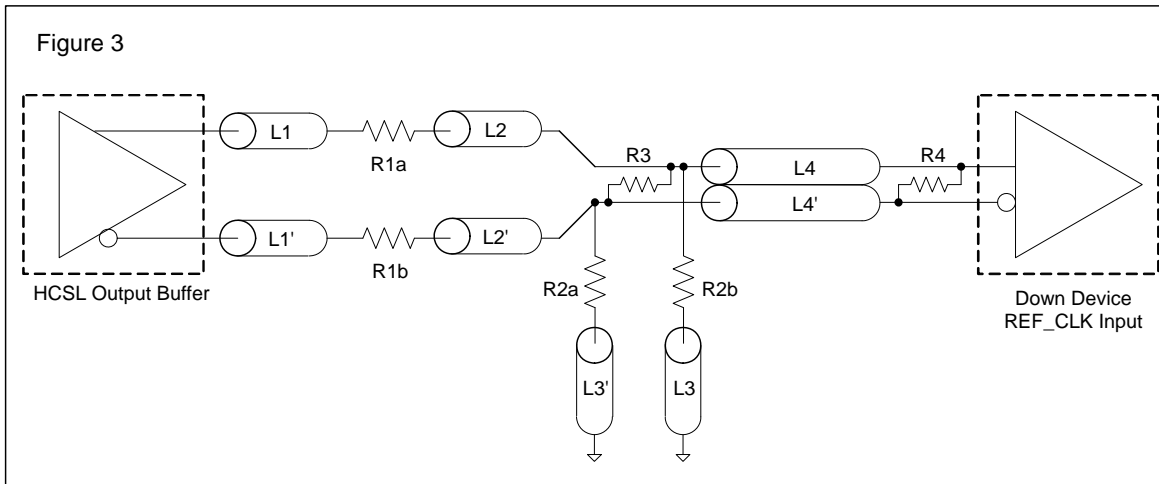


**Alternative Termination for LVDS and other Common Differential Signals (figure 3)**

Vdiff	Vp-p	Vcm	R1	R2	R3	R4	Note
0.45v	0.22v	1.08	33	150	100	100	
0.58	0.28	0.6	33	78.7	137	100	
0.80	0.40	0.6	33	78.7	none	100	ICS874003i-02 input compatible
0.60	0.3	1.2	33	174	140	100	Standard LVDS

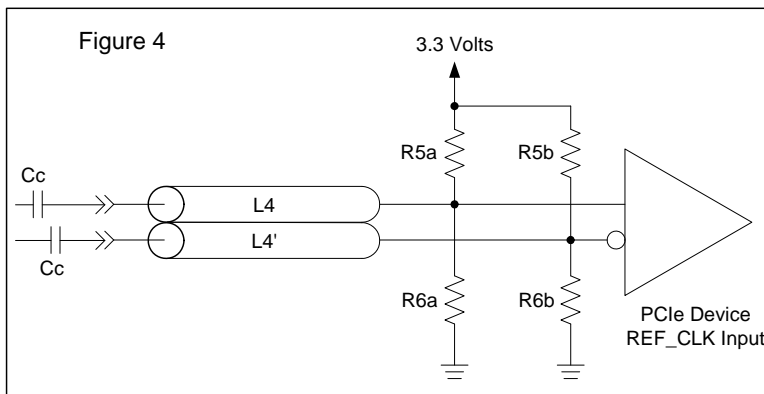
R1a = R1b = R1

R2a = R2b = R2

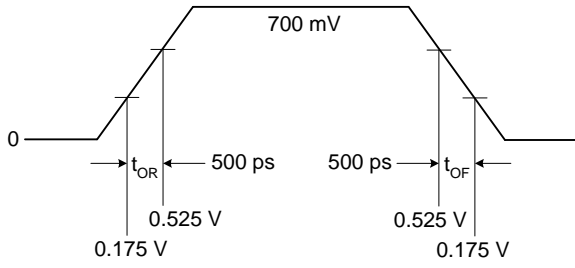


**Cable Connected AC Coupled Application (figure 4)**

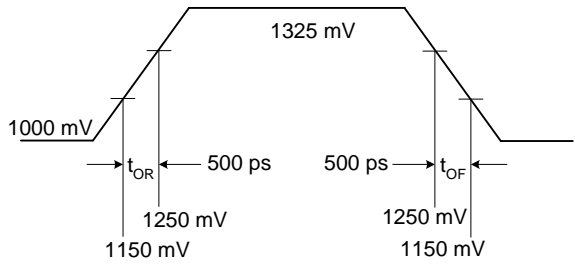
Component	Value	Note
R5a, R5b	8.2K 5%	
R6a, R6b	1K 5%	
Cc	0.1 μF	
Vcm	0.350 volts	



### Typical PCI-Express (HCSL) Waveform



### Typical LVDS Waveform



## Absolute Maximum Ratings

Stresses above the ratings listed below can cause permanent damage to the IDT5V41065. These ratings are stress ratings only. Functional operation of the device at these or any other conditions above those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods can affect product reliability. Electrical parameters are guaranteed only over the recommended operating temperature range.

Item	Rating
Supply Voltage, VDDXD, VDDODA	4.6 V
All Inputs and Outputs	-0.5 V to VDD+0.5 V
Ambient Operating Temperature (commercial)	0 to +70° C
Ambient Operating Temperature (industrial)	-40 to +85° C
Storage Temperature	-65 to +150° C
Junction Temperature	125° C
Soldering Temperature	260° C
ESD Protection (Input)	2000 V min. (HBM)

## DC Electrical Characteristics

Unless stated otherwise, VDD = 3.3 V  $\pm$ 5%, Ambient Temperature -40 to +85° C

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Units
Supply Voltage	V		3.135	3.3	3.465	V
Input High Voltage <sup>1</sup>	V <sub>IH</sub>	S0, S1, OE, ICLK, SS0, SS1	2.2		VDD +0.3	V
Input Low Voltage <sup>1</sup>	V <sub>IL</sub>	S0, S1, OE, ICLK, SS0, SS1	VSS-0.3		0.8	V
Input Leakage Current <sup>2</sup>	I <sub>IL</sub>	0 < V <sub>in</sub> < VDD	-5		5	$\mu$ A
Operating Supply Current @ 100 MHz	I <sub>DD</sub>	R <sub>S</sub> =33 $\Omega$ R <sub>P</sub> =50 $\Omega$ C <sub>L</sub> =2 pF		63	85	mA
	I <sub>DDOE</sub>	OE =Low		42	50	mA
Input Capacitance	C <sub>IN</sub>	Input pin capacitance			7	pF
Output Capacitance	C <sub>OUT</sub>	Output pin capacitance			6	pF
X1, X2 Capacitance	C <sub>INX</sub>				5	pF
Pin Inductance	L <sub>PIN</sub>				5	nH
Output Impedance	Z <sub>O</sub>	CLK outputs	3.0			k $\Omega$
Pull-up Resistor	R <sub>PU</sub>	S0, S1, OE, SS0, SS1		100		k $\Omega$

1. Single edge is monotonic when transitioning through region.
2. Inputs with pull-ups/-downs are not included.

## AC Electrical Characteristics - CLK0/CLK1, $\overline{\text{CLK0/CLK1}}$

Unless stated otherwise, VDD=3.3 V  $\pm$ 5%, Ambient Temperature -40 to +85° C

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Units
Input Frequency				25		MHz
Output Frequency		HCSL termination	25		200	MHz
		LVDS termination	25		100	MHz
Output High Voltage <sup>1,2</sup>	V <sub>OH</sub>	HCSL			850	mV
Output Low Voltage <sup>1,2</sup>	V <sub>OL</sub>	HCSL	-150			mV
Crossing Point Voltage <sup>1,2</sup>		Absolute	250		550	mV
Crossing Point Voltage <sup>1,2,4</sup>		Variation over all edges			140	mV
Jitter, Cycle-to-Cycle <sup>1,3</sup>					100	ps
Frequency Synthesis Error		All outputs		0		ppm
Modulation Frequency		Spread spectrum	30	32.9	33	kHz
Rise Time <sup>1,2</sup>	t <sub>OR</sub>	From 0.175 V to 0.525 V	175		700	ps
Fall Time <sup>1,2</sup>	t <sub>OF</sub>	From 0.525 V to 0.175 V	175		700	ps
Rise/Fall Time Variation <sup>1,2</sup>					125	ps
Output to Output Skew					50	ps
Duty Cycle <sup>1,3</sup>			45		55	%
Output Enable Time <sup>5</sup>		All outputs		50	100	ns
Output Disable Time <sup>5</sup>		All outputs		50	100	ns
Stabilization Time	t <sub>STABLE</sub>	From power-up VDD=3.3 V			1.8	ms
Spread Spectrum Transition Time	t <sub>SPREAD</sub>	Stabilization time after spread spectrum changes	7		30	ms

Note 1: Test setup is R<sub>S</sub>=33Ω, R<sub>P</sub>=50Ω with C<sub>L</sub>=2 pF, R<sub>r</sub> = 475Ω (1%).

Note 2: Measurement taken from a single-ended waveform.

Note 3: Measurement taken from a differential waveform.

Note 4: Measured at the crossing point where instantaneous voltages of both CLK and  $\overline{\text{CLK}}$  are equal.

Note 5: CLK pins are tri-stated when OE is low asserted. CLK is driven differential when OE is high.

## Electrical Characteristics - Differential Phase Jitter

Parameter	Symbol	Conditions	Min	Typ	Max	Units	Notes
Jitter, Phase	t <sub>jphasePLL</sub>	PCIe Gen1		32	86	ps (p-p)	1,2,3
	t <sub>jphaseLO</sub>	PCIe Gen2, 10 kHz < f < 1.5 MHz		0.8	3	ps (RMS)	1,2,3
	t <sub>jphaseHIGH</sub>	PCIe Gen2, 1.5 MHz < f < Nyquist (50 MHz)		2.3	3.1	ps (RMS)	1,2,3

Note 1. Guaranteed by design and characterization, not 100% tested in production.

Note 2. See <http://www.pcisig.com> for complete specs.

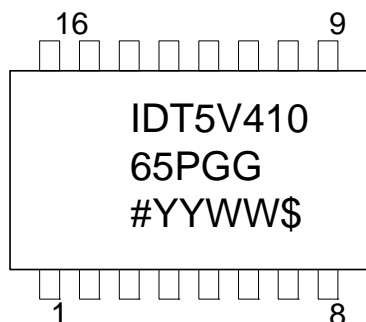
Note 3: Applies to 100MHz, spread off and 0.5% down spread only.



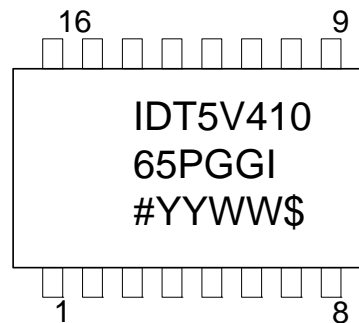
## Thermal Characteristics

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Units
Thermal Resistance Junction to Ambient	$\theta_{JA}$	Still air		78		°C/W
	$\theta_{JA}$	1 m/s air flow		70		°C/W
	$\theta_{JA}$	3 m/s air flow		68		°C/W
Thermal Resistance Junction to Case	$\theta_{JC}$			37		°C/W

### Marking Diagram (5V41065PGG)



### Marking Diagram (5V41065PGGI)

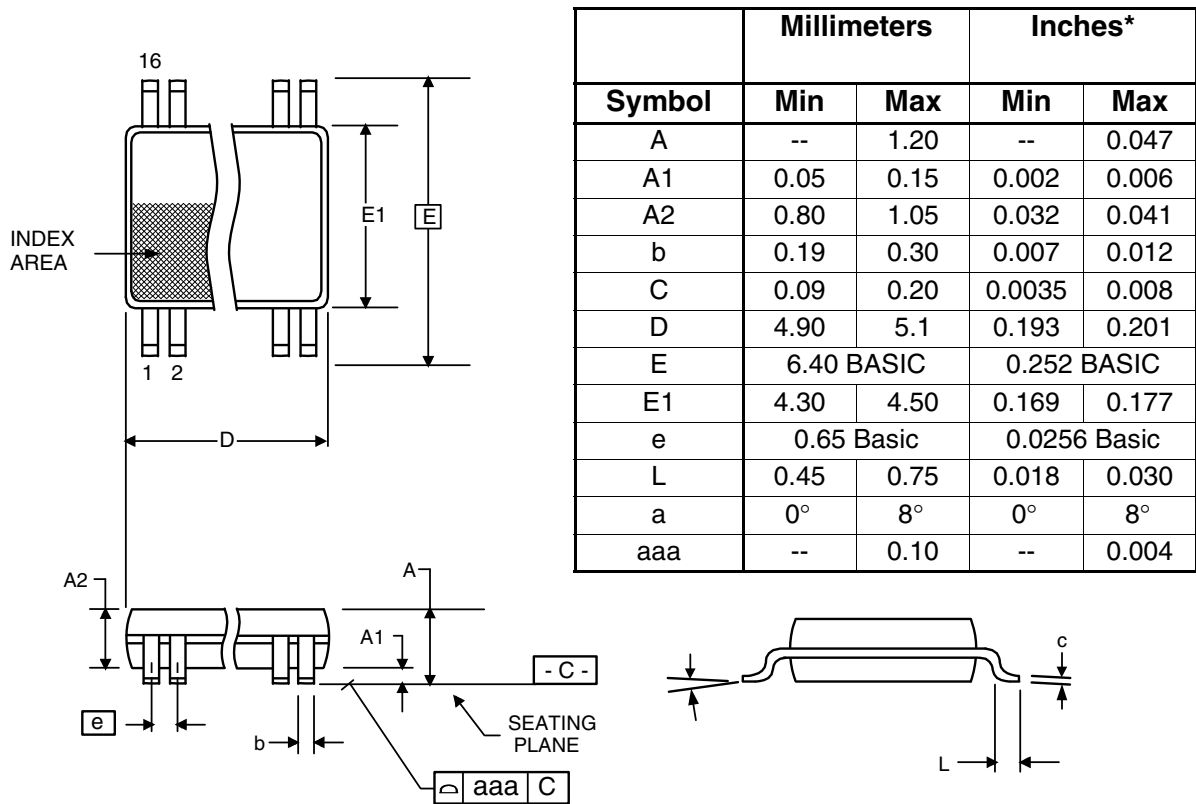


Notes:

1. Line 1 and 2: IDT part number.
2. Line 3: # – Die revision; YYWW – Date code; \$ – Assembly location.
3. “G” after the two-letter package code designates RoHS compliant package.
4. “I” at the end of part number indicates industrial temperature range.
5. Bottom marking: country of origin if not USA.

## Package Outline and Package Dimensions (16-pin TSSOP, 173 Mil. Narrow Body)

Package dimensions are kept current with JEDEC Publication No. 95



## Ordering Information

Part / Order Number	Marking	Shipping Packaging	Package	Temperature
5V41065PGG	See Page 8	Tubes	16-pin TSSOP	0 to +70° C
5V41065PGG8		Tape and Reel	16-pin TSSOP	0 to +70° C
5V41065PGGI	See Page 8	Tubes	16-pin TSSOP	-40 to +85° C
5V41065PGGI8		Tape and Reel	16-pin TSSOP	-40 to +85° C

“G” after the two-letter package code are the Pb-Free configuration and are RoHS compliant.

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## Revision History

Rev.	Originator	Date	Description of Change
A		07/15/08	New datasheet; Preliminary initial release.
B	RDW	01/13/10	Added Gen2 to title; update Electrical tables per char; added Differential Phase Jitter table.
C	RDW	04/27/10	Updated electrical tables per char; VDD is now 3.3 $\pm$ 5%; released to final.
D	RDW	07/19/10	1. Updated title and general decription 2. Updated cycle-to-cycle jitter spec from 125 to 100 ps.
E	RDW	11/21/11	1. Changed title to "2 Output PCIe GEN1/2 Synthesizer" 2. Added note to Features section: "For PCIe Gen3 applications, see 5V41235" 3. Updated Differential Phase Jitter table.

**IDT5V41065**

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